

Search Notes

Application/Control No.

10/648,367

Examiner

Julie E. Stein, Esq.

Applicant(s)/Patent under
Reexamination

IIDA, TAKAYUKI

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
348	211.2	3/21/2006	JES
348	211.14	3/21/2006	JES

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT,PGPUB-text search--see attached	3/21/2006	JES
EPO,JPO,DERWENT-text search-see attached	3/21/2006	JES